





SN74AHC1G86-Q1 SCLS723B - APRIL 2011 - REVISED FEBRUARY 2024

SN74AHC1G86-Q1 Automotive Single 2-Input Exclusive-OR Gate

1 Features

Texas

INSTRUMENTS

- Qualified for automotive applications
- AEC-Q100 qualified with the following results:
 - ±4000V Human-Body Model (HBM) ESD **Classification Level 3A**
 - ±1000V Charged-Device Model (CDM) ESD **Classification Level C5**
- Operating range of 2V to 5.5V
- Maximum t_{pd} of 10ns at 5V •
- Low power consumption, 10µA maximum I_{CC} •
- ±8mA output drive at 5V
- Schmitt-trigger action at all inputs makes the circuit • tolerant for slower input rise and fall time

2 Applications

- Wireless headsets •
- Motor drives and controls
- TVs
- Set-top boxes
- Audio



The SN74AHC1G86-Q1 is a single 2-input exclusive-OR gate. The device performs the Boolean function Y = A \oplus B or Y = \overline{AB} + A \overline{B} in positive logic.

A common application is as a true/complement element. If one of the inputs is low, the other input is reproduced in true form at the output. If one of the inputs is high, the signal on the other input is reproduced inverted at the output.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾	BODY SIZE (3)
SN74AHC1G86-Q1	DBV (SOT-23, 5)	2.90mm × 2.8mm	2.90mm x 1.60mm

For more information, see Section 11. (1)

- The package size (length × width) is a nominal value and (2)includes pins, where applicable.
- (3) The body size (length × width) is a nominal value and does not include pins.

EXCLUSIVE OR



Copyright © 2017, Texas Instruments Incorporated

Functional Block Diagram





Table of Contents

1 Features	1
2 Applications	1
3 Description	
4 Pin Configuration and Functions	3
5 Specifications	4
5.1 Absolute Maximum Ratings	4
5.2 ESD Ratings	
5.3 Recommended Operating Conditions	4
5.4 Thermal Information	5
5.5 Electrical Characteristics	5
5.6 Switching Characteristics, V _{CC} = 3.3V ±0.3V	5
5.7 Switching Characteristics, V _{CC} = 5V ±0.5 V	5
5.8 Operating Characteristics	6
5.9 Typical Characteristics	6
6 Parameter Measurement Information	7
7 Detailed Description	<mark>8</mark>
7.1 Overview	<mark>8</mark>
7.2 Functional Block Diagram	8

7.3 Feature Description	8
7.4 Device Functional Modes	
8 Application and Implementation	10
8.1 Application Information	
8.2 Typical Application	10
8.3 Power Supply Recommendations	11
8.4 Layout	11
9 Device and Documentation Support	13
9.1 Community Resources	13
9.2 Receiving Notification of Documentation Updates.	
9.3 Support Resources	13
9.4 Trademarks	13
9.5 Electrostatic Discharge Caution	
9.6 Glossary	13
10 Revision History	13
11 Mechanical, Packaging, and Orderable	
Information	14



4 Pin Configuration and Functions

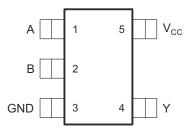


Figure 4-1. DBV Package 5-Pin SOT-23 Top View

Table 4-1. Pin Functions

	PIN	I/O	DESCRIPTION
NO.	NAME	1/0	DESCRIPTION
1	A	I	Input A
2	В	I	Input B
3	GND	—	Ground
4	Y	0	Output Y
5	V _{CC}	—	Positive Supply



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
VI	Input voltage range ⁽²⁾	Input voltage range ⁽²⁾		7	V
Vo	Output voltage range applied in the high-	or low-state ⁽²⁾	-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	(V _I < 0V)		-20	V
I _{OK}	Output clamp current	$(V_O < 0V \text{ or } V_O > V_{CC})$		±20	mA
I _O	Continuous output current	$(V_{O} = 0V \text{ to } V_{CC})$		±25	mA
	Continuous current through V_{CC} or GND			±50	mA
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

5.2 ESD Ratings

			VALUE	UNIT
V		Human-body model (HBM), per AEC Q100-002 ⁽¹⁾	±4000	V
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per AEC Q100-011	±1000	v

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage		2	5.5	V
		V _{CC} = 2V	1.5		
V _{IH}	High-level input voltage	V _{CC} = 3V	2.1		V
		V _{CC} = 5.5V	3.85		
		V _{CC} = 2V		0.5	
VIL	Low-level input voltage	V _{CC} = 3V		0.9	V
		V _{CC} = 5.5V		1.65	
VI	Input voltage		0	5.5	V
Vo	Output voltage		0	V _{CC}	V
	High-level output current	V _{CC} = 2V		-50	μA
I _{ОН}		$V_{CC} = 3.3V \pm 0.3V$		-4	mA
		$V_{CC} = 5V \pm 0.5V$		-8	
		V _{CC} = 2V		50	μA
l _{ol}	Low-level output current	$V_{CC} = 3.3V \pm 0.3V$		4	
		$V_{CC} = 5V \pm 0.5V$		8	mA
Δt/ΔV		V _{CC} = 3.3V ±0.3V		100	
	Input transition rise or fall rate	$V_{CC} = 5V \pm 0.5V$		20	ns/V
T _A	Operating free-air temperature		-40	125	°C

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.



5.4 Thermal Information

		SN74AHC1G86-Q1	
	THERMAL METRIC ⁽¹⁾	DBV (SOT-23)	UNIT
		5 PINS	-
R _{0JA}	Junction-to-ambient thermal resistance	278	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	180.5	°C/W
R _{θJB}	Junction-to-board thermal resistance	184.4	°C/W
ΨJT	Junction-to-top characterization parameter	115.4	°C/W
Ψ _{JB}	Junction-to-board characterization parameter	183.4	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

5.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{cc}	Т	T _A = 25°C			МАХ	UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	IVIAA	UNIT
		2V	1.9	2		1.9		
	I _{OH} = -50μA	3V	2.9	3		2.9		
V _{OH}		4.5V	4.4	4.5		4.4		V
	I _{OH} = -4mA	3V	2.58			2.48		
	I _{OH} = -8mA	4.5V	3.94			3.8		
		2V			0.1		0.1	
	Ι _{ΟL} = 50μΑ	3V			0.1		0.1	
V _{OL}		4.5V			0.1		0.1	V
	I _{OL} = 4mA	3V			0.36		0.44	
	I _{OL} = 8mA	4.5V			0.36		0.44	
I _I	V _I = 5.5V or GND	0V to 5.5V			±0.1		±1	μA
I _{CC}	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0 \text{ A}$	5.5V			1		10	μA
CI	V _I = V _{CC} or GND	5V		4	10		10	pF

5.6 Switching Characteristics, V_{CC} = 3.3V ±0.3V

over recommended operating free-air temperature range, V_{CC} = 3.3V ±0.3V, T_A = -40°C to 125°C, see Load Circuit and Voltage Waveforms

PARAMETER	FROM	то	LOAD T _A = 25°C			MIN	МАХ	UNIT	
	(OUT) (OUT	(OUTPUT)	UTPUT) CAPACITANCE	MIN	TYP	MAX	WIIIN		
t _{PLH}	A or B Y	V	C _L = 50pF -		9.5	14.5	1	16.5	
t _{PHL}	AUB	ſ		$C_L = 50 pF$		9.5	14.5	1	16.5

5.7 Switching Characteristics, V_{CC} = 5V ±0.5 V

over recommended operating free-air temperature range, V_{CC} = 5V ±0.5V, T_A = -40°C to 125°C, see Load Circuit and Voltage Waveforms

PARAMETER	FROM	то	TO LOAD		T _A = 25°C			МАХ	UNIT
PARAIVIETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MIAA	UNIT
t _{PLH}	A or B	V	$C_{\rm c} = 50 \rm pE$		6.3	8.8	1	10	ns
t _{PHL}	AUB	I	C _L = 50pF		6.3	8.8	1	10	115

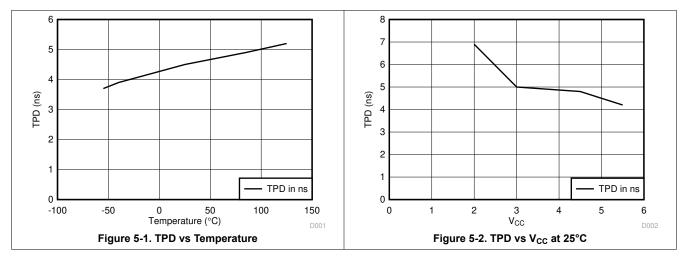


5.8 Operating Characteristics

 V_{CC} = 5V, T_{A} = 25°C

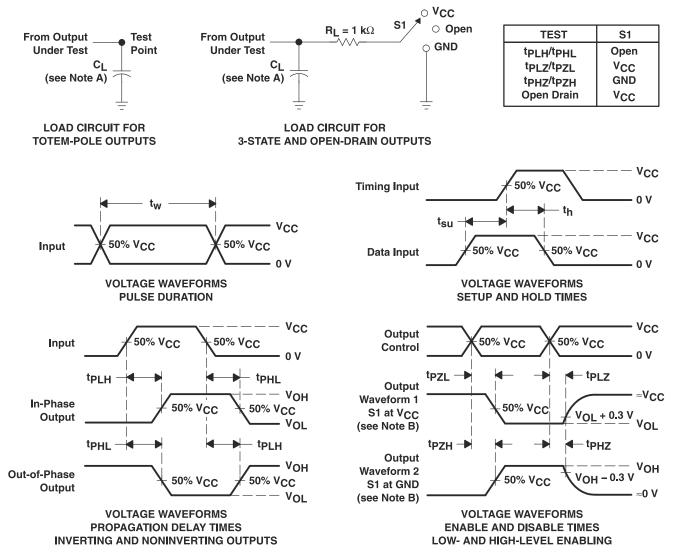
PARAMETER		TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load, f = 1MHz	18	pF

5.9 Typical Characteristics





6 Parameter Measurement Information



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_Q = 50 Ω , t_r \leq 3 ns, t_f \leq 3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.

Figure 6-1. Load Circuit and Voltage Waveforms



7 Detailed Description

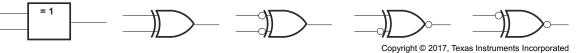
7.1 Overview

The SN74AHC1G86-Q1 is an automotive qualified device that performs the Boolean function $Y = \overline{AB} + A \overline{B}$ in positive logic. This single 2-input exclusive-OR gate is designed for 2V to 5.5V V_{CC} operation.

A common application is as a true or complementary element. If one of the inputs is low, the other input is reproduced in true form at the output. If one of the inputs is high, the signal on the other input is reproduced inverted at the output.

7.2 Functional Block Diagram

EXCLUSIVE OR



These are five equivalent exclusive-OR symbols valid for an SN74AHC1G86-Q1 gate in positive logic; negation may be shown at any two ports.

7.3 Feature Description

7.3.1 Balanced CMOS Push-Pull Outputs

A balanced output allows the device to sink and source similar currents. The drive capability of this device may create fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to over-current. The electrical and thermal limits defined the in the must be followed at all times.

7.3.2 Standard CMOS Inputs

Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the . The worst case resistance is calculated with the maximum input voltage, given in the , and the maximum input leakage current, given in the , using ohm's law ($R = V \div I$).

Signals applied to the inputs need to have fast edge rates, as defined by $\Delta t/\Delta v$ in to avoid excessive current consumption and oscillations. If a slow or noisy input signal is required, a device with a Schmitt-trigger input should be used to condition the input signal prior to the standard CMOS input.

7.3.3 Clamping Diodes

The inputs have negative clamping diodes, and the outputs have positive and negative clamping diodes as depicted in Figure 7-1.

CAUTION

Voltages beyond the values specified in the table can cause damage to the device. The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.



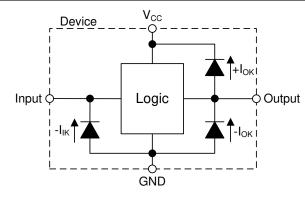


Figure 7-1. Electrical Placement of Clamping Diodes for Each Input and Output

7.3.4 Over-voltage Tolerant Inputs

Input signals to this device can be driven above the supply voltage so long as they remain below the maximum input voltage value specified in the .

7.4 Device Functional Modes

Table 7-1 lists the functional modes of the SN74AHC1G86-Q1 device.

INP	UTS	OUTPUT						
Α	В	Y						
L	L	L						
L	Н	н						
Н	L	н						
Н	Н	L						

Table 7-1. Function Table



8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The SN74AHC1G86-Q1 is a low-drive CMOS device that can be used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs. The inputs can accept voltages to 5.5V at any valid V_{CC} making it ideal for down translation.

8.2 Typical Application

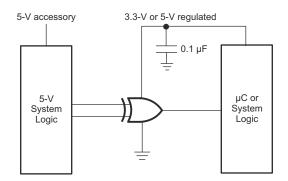


Figure 8-1. Typical Application Schematic

8.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits.

8.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
 - For rise time and fall time specifications, see $\Delta t/\Delta V$ in the table.
 - For specified High and low levels, see V_{IH} and V_{IL} in the table.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5V at any valid V_{CC}.
- 2. Recommended Output Conditions
 - · Load currents should not exceed 8mA per output.
 - Outputs should not be pulled above $V_{\mbox{\scriptsize CC}}.$



8.2.3 Application Curve

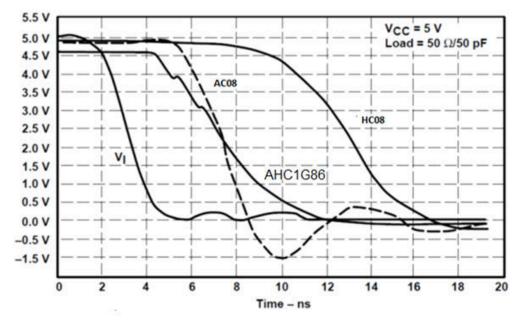


Figure 8-2. Switching Characteristics Comparison

8.3 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the table.

Each V_{CC} pin must have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1μ F is recommended. If there are multiple V_{CC} pins, 0.01μ F or 0.022μ F is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1μ F and 1μ F are commonly used in parallel. The bypass capacitor must be installed as close to the power pin as possible for best results.

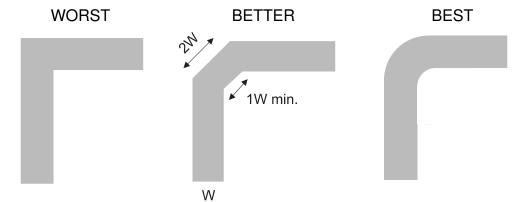
8.4 Layout

8.4.1 Layout Guidelines

Even low data rate digital signals can have high frequency signal components due to fast edge rates. When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.



8.4.2 Layout Example







9 Device and Documentation Support

9.1 Community Resources

9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments. All trademarks are the property of their respective owners.

9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (May 2019) to Revision B (February 2024)

Changes from Revision * (April 2011) to Revision A (May 2019)

_		
•	Changed Features section	1
•	Added Applications section	1
•	Changed Description section	1
•	Changed Pin Configuration and Functions section	3
•	Added T _J spec to Absolute Maximum Ratings table	4
	Changed T _{stg} to -65° (min) and 150°C (max) from -40°C (min) and 125°C (max)	
	Added ESD Ratings table	
•	Added Thermal Information table	5
•	Added Typical Characteristics section	6
•	Added Application and Implementation section	10
	Added Power Supply Recommendations section	

Page

Page



11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
	()	()				(4)	(5)		(-)
SN74AHC1G86QDBVRQ1	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	(39KH, ACYU)
SN74AHC1G86QDBVRQ1.A	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	(39KH, ACYU)

⁽¹⁾ **Status:** For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74AHC1G86-Q1 :

Catalog : SN74AHC1G86



23-May-2025

Enhanced Product : SN74AHC1G86-EP

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

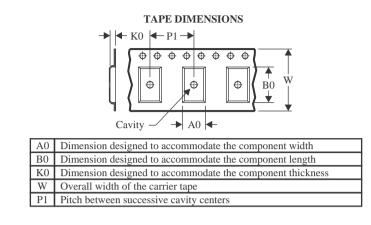
• Enhanced Product - Supports Defense, Aerospace and Medical Applications



www.ti.com

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHC1G86QDBVRQ1	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3



www.ti.com

PACKAGE MATERIALS INFORMATION

22-Apr-2025



*All	dimensions	are	nominal
------	------------	-----	---------

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHC1G86QDBVRQ1	SOT-23	DBV	5	3000	210.0	185.0	35.0

DBV0005A



PACKAGE OUTLINE

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.
 Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



DBV0005A

EXAMPLE BOARD LAYOUT

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DBV0005A

EXAMPLE STENCIL DESIGN

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025, Texas Instruments Incorporated